# 30V, N-Channel NexFET™ Power MOSFETs

**Check for Samples: CSD17527Q5A**

## FEATURES

- **Ultralow $Q_g$ and $Q_{gd}$**
- **Low Thermal Resistance**
- **Avalanche Rated**
- **Pb Free Terminal Plating**
- **RoHS Compliant**
- **Halogen Free**
- **SON 5-mm × 6-mm Plastic Package**

## APPLICATIONS

- **Point-of-Load Synchronous Buck in Networking, Telecom and Computing Systems**
- **Optimized for Control FET Applications**

## DESCRIPTION

The NexFET™ power MOSFET has been designed to minimize losses in power conversion applications.

**Top View**

P0093-01
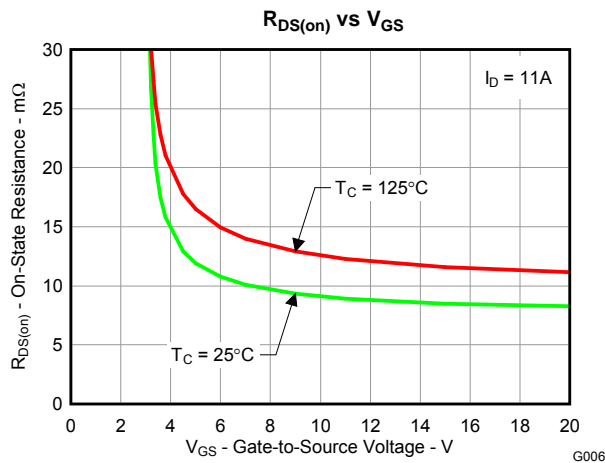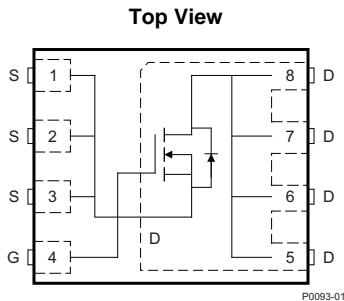
## PRODUCT SUMMARY

| | | | | |
|---|---|---|---|---|
| $V_{DS}$ | Drain to Source Voltage | | 30 | V |
| $Q_g$ | Gate Charge Total (4.5V) | | 2.8 | nC |
| $Q_{gd}$ | Gate Charge Gate to Drain | | 0.8 | nC |
| $R_{DS(on)}$ | Drain to Source On Resistance | $V_{GS}$ = 4.5V | 12.5 | mΩ |
| | | $V_{GS}$ = 10V | 9.3 | mΩ |
| $V_{GS(th)}$ | Threshold Voltage | | 1.6 | V |

## ORDERING INFORMATION

| Device | Package | Media | Qty | Ship |
|---|---|---|---|---|
| CSD17527Q5A | SON 5-mm × 6-mm Plastic Package | 13-Inch Reel | 2500 | Tape and Reel |

## ABSOLUTE MAXIMUM RATINGS

| $T_A$ = 25°C unless otherwise stated | | VALUE | UNIT |
|---|---|---|---|
| $V_{DS}$ | Drain to Source Voltage | 30 | V |
| $V_{GS}$ | Gate to Source Voltage | ±20 | V |
| $I_D$ | Continuous Drain Current, $T_C$ = 25°C | 65 | A |
| | Continuous Drain Current[1] | 13 | A |
| $I_{DM}$ | Pulsed Drain Current, $T_A$ = 25°C[2] | 85 | A |
| $P_D$ | Power Dissipation[1] | 3 | W |
| $T_J$, $T_{STG}$ | Operating Junction and Storage Temperature Range | −55 to 150 | °C |
| $E_{AS}$ | Avalanche Energy, single pulse $I_D$ = 30A, L = 0.1mH, $R_G$ = 25Ω | 45 | mJ |

(1) Typical $R_{\theta JA}$ = 44°C/W on 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 0.06-inch (1.52-mm) thick FR4 PCB.

(2) Pulse duration ≤300µs, duty cycle ≤2%

**$R_{DS(on)}$ vs $V_{GS}$**

G006

**GATE CHARGE**

G003
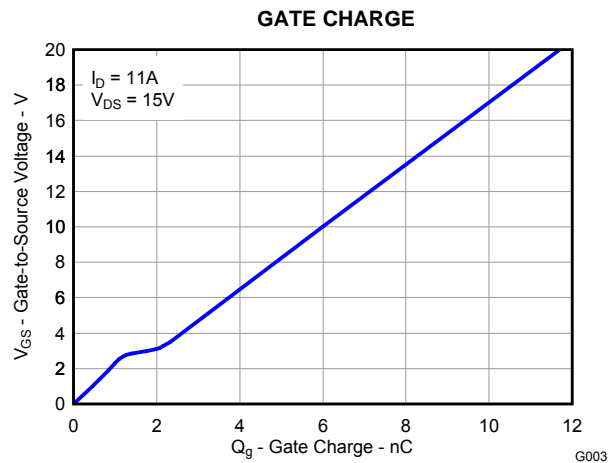
⚠ Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.
NexFET is a trademark of Texas Instruments.

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## ELECTRICAL CHARACTERISTICS

($T_A$ = 25°C unless otherwise stated)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|---|
| **Static Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain to Source Voltage | $V_{GS}$ = 0V, $I_{DS}$ = 250µA | 30 | | | V |
| $I_{DSS}$ | Drain to Source Leakage Current | $V_{GS}$ = 0V, $V_{DS}$ = 24V | | | 1 | µA |
| $I_{GSS}$ | Gate to Source Leakage Current | $V_{DS}$ = 0V, $V_{GS}$ = ±20V | | | 100 | nA |
| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{DS}$ = $V_{GS}$, $I_{DS}$ = 250µA | 1.1 | 1.6 | 2.0 | V |
| $R_{DS(on)}$ | Drain to Source On Resistance | $V_{GS}$ = 4.5V, $I_{DS}$ = 11A | | 12.5 | 15.5 | mΩ |
| | | $V_{GS}$ = 10V, $I_{DS}$ = 11A | | 9.3 | 10.8 | mΩ |
| $g_{fs}$ | Transconductance | $V_{DS}$ = 15V, $I_{DS}$ = 11A | | 44 | | S |
| **Dynamic Characteristics** | | | | | | |
| $C_{iss}$ | Input Capacitance | $V_{GS}$ = 0V, $V_{DS}$ = 15V, f = 1MHz | | 422 | 506 | pF |
| $C_{oss}$ | Output Capacitance | | | 286 | 343 | pF |
| $C_{rss}$ | Reverse Transfer Capacitance | | | 26 | 33 | pF |
| $R_G$ | Series Gate Resistance | | | 4.7 | | Ω |
| $Q_g$ | Gate Charge Total (4.5V) | $V_{DS}$ = 15V, $I_{DS}$ = 11A | | 2.8 | 3.4 | nC |
| $Q_{gd}$ | Gate Charge Gate to Drain | | | 0.8 | | nC |
| $Q_{gs}$ | Gate Charge Gate to Source | | | 1.2 | | nC |
| $Q_{g(th)}$ | Gate Charge at Vth | | | 0.6 | | nC |
| $Q_{oss}$ | Output Charge | $V_{DS}$ = 13V, $V_{GS}$ = 0V | | 6.8 | | nC |
| $t_{d(on)}$ | Turn On Delay Time | $V_{DS}$ = 15V, $V_{GS}$ = 4.5V, $I_{DS}$ = 11A, $R_G$ = 2Ω | | 5.6 | | ns |
| $t_r$ | Rise Time | | | 8.2 | | ns |
| $t_{d(off)}$ | Turn Off Delay Time | | | 9.8 | | ns |
| $t_f$ | Fall Time | | | 3.2 | | ns |
| **Diode Characteristics** | | | | | | |
| $V_{SD}$ | Diode Forward Voltage | $I_{SD}$ = 11A, $V_{GS}$ = 0V | | 0.85 | 1 | V |
| $Q_{rr}$ | Reverse Recovery Charge | $V_{DS}$= 13V, $I_F$ = 11A, di/dt = 300A/µs | | 10.5 | | nC |
| $t_{rr}$ | Reverse Recovery Time | | | 14.6 | | ns |

## THERMAL CHARACTERISTICS

($T_A$ = 25°C unless otherwise stated)

| PARAMETER | | MIN | TYP | MAX | UNIT |
|---|---|---|---|---|---|
| $R_{\theta JC}$ | Thermal Resistance Junction to Case[1] | | | 1.9 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance Junction to Ambient[1][2] | | | 51 | °C/W |

(1) $R_{\theta JC}$ is determined with the device mounted on a 1-inch$^2$ (6.45-cm$^2$), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inch × 1.5-inch (3.81-cm × 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. $R_{\theta JC}$ is specified by design, whereas $R_{\theta JA}$ is determined by the user's board design.
(2) Device mounted on FR4 material with 1-inch$^2$ (6.45-cm$^2$), 2-oz. (0.071-mm thick) Cu.

GATE ◯ ◯ Source

N-Chan 5x6 QFN TTA MAX Rev3

◯ DRAIN
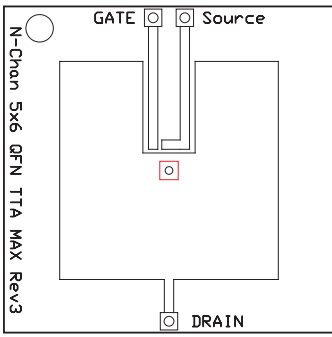
Max $R_{\theta JA}$ = 51°C/W when mounted on 1 inch$^2$ (6.45 cm$^2$) of 2-oz. (0.071-mm thick) Cu.

M0137-01

GATE ◯ ◯ Source

N-Chan 5x6 QFN TTA MIN Rev3

◯ DRAIN
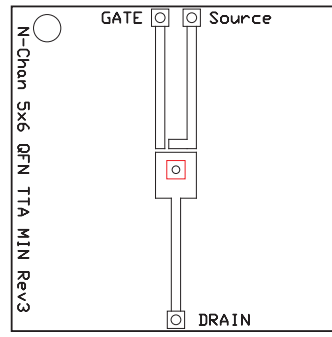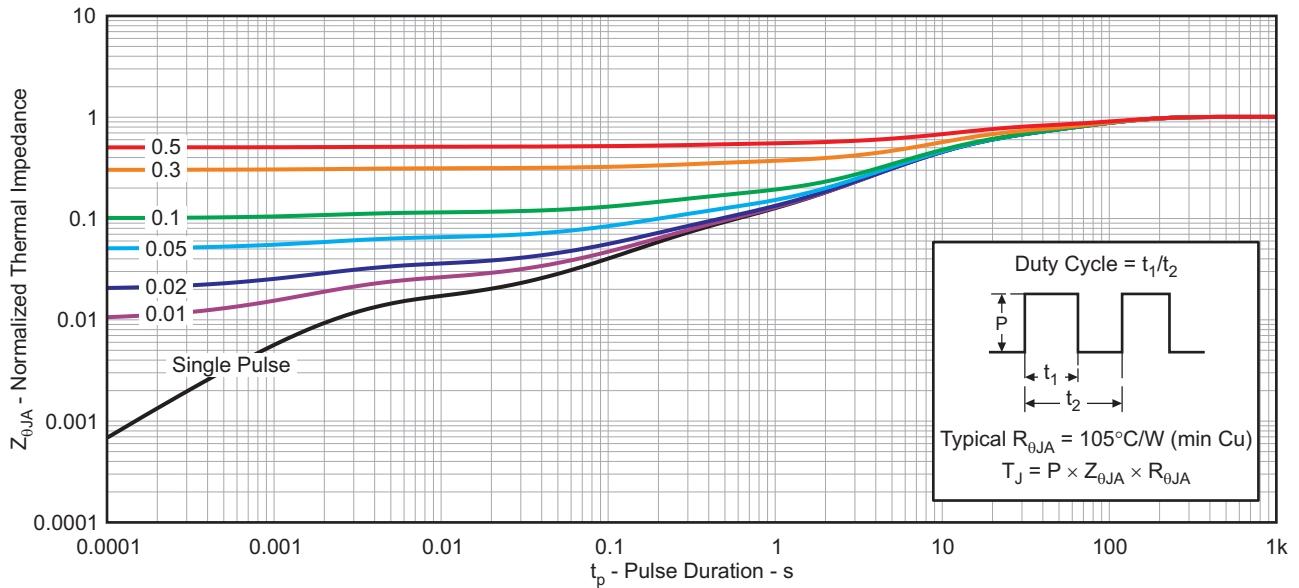
Max $R_{\theta JA}$ = 131°C/W when mounted on a minimum pad area of 2-oz. (0.071-mm thick) Cu.

M0137-02

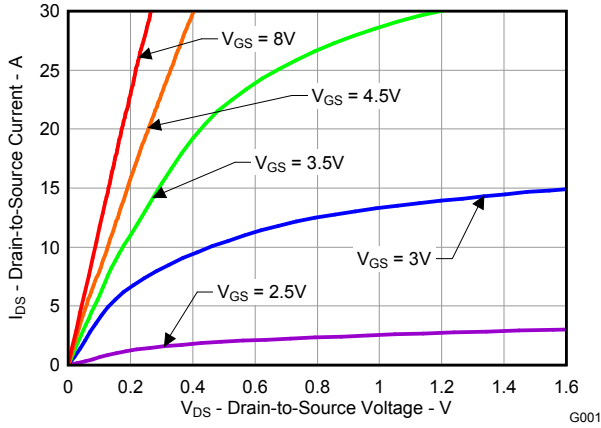## TYPICAL MOSFET CHARACTERISTICS

($T_A$ = 25°C unless otherwise stated)



Z$_{\theta JA}$ - Normalized Thermal Impedance

0.5
0.3
0.1
0.05
0.02
0.01

Single Pulse

Duty Cycle = $t_1/t_2$

P

$t_1$
$t_2$

Typical $R_{\theta JA}$ = 105°C/W (min Cu)

$T_J = P \times Z_{\theta JA} \times R_{\theta JA}$

$t_p$ - Pulse Duration - s

G012

**Figure 1. Transient Thermal Impedance**

# CSD17527Q5A

SLPS331A –JUNE 2011–REVISED AUGUST 2011

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# TYPICAL MOSFET CHARACTERISTICS (continued)
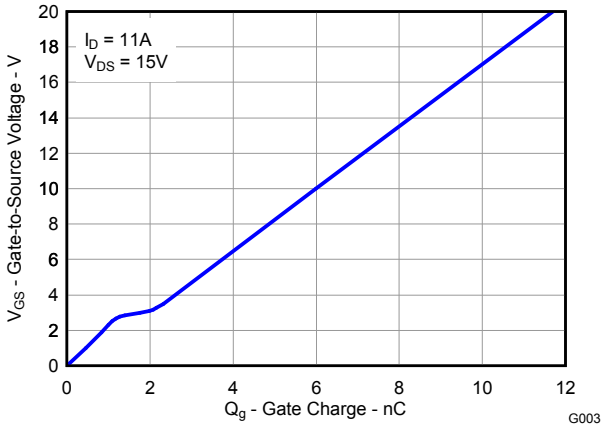
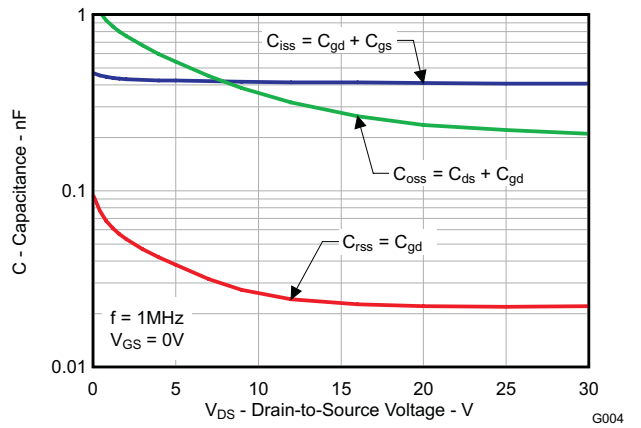($T_A$ = 25°C unless otherwise stated)
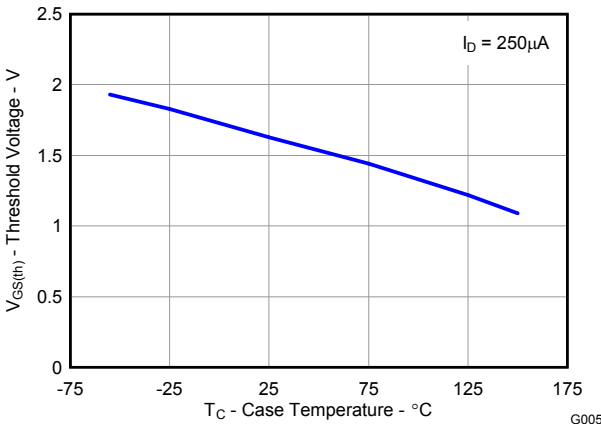
**Figure 2. Saturation Characteristics**
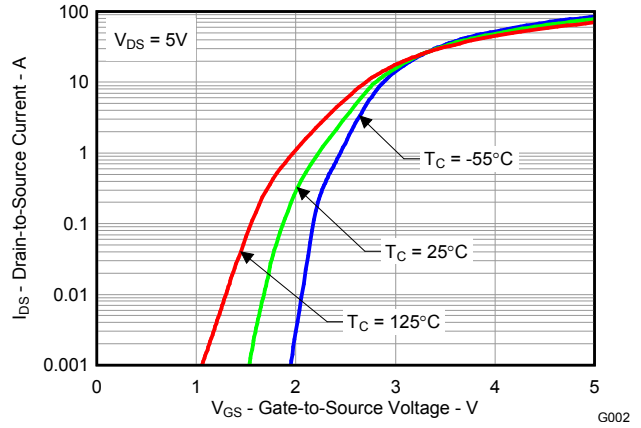
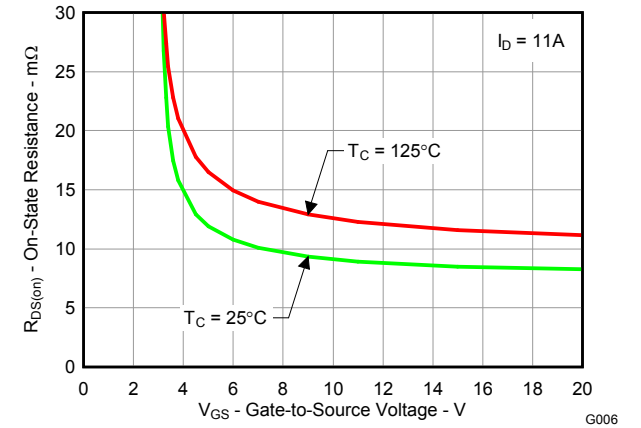**Figure 3. Transfer Characteristics**

**Figure 4. Gate Charge**

**Figure 5. Capacitance**

**Figure 6. Threshold Voltage vs. Temperature**

**Figure 7. On-State Resistance vs. Gate-to-Source Voltage**

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## TYPICAL MOSFET CHARACTERISTICS (continued)

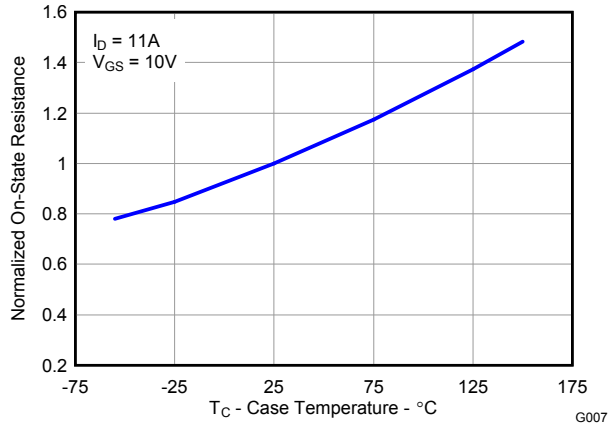($T_A$ = 25°C unless otherwise stated)

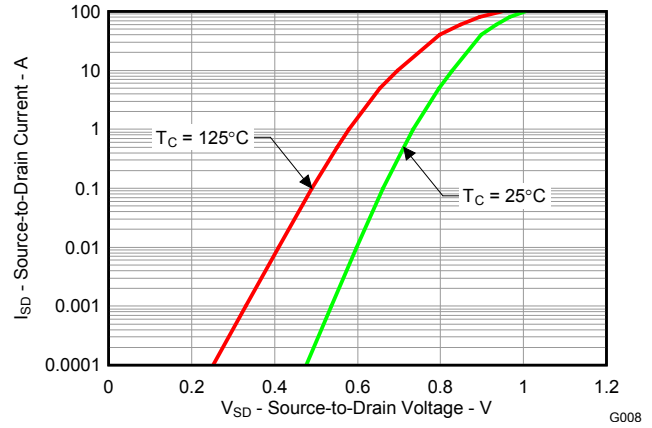**Figure 8. Normalized On-State Resistance vs. Temperature**

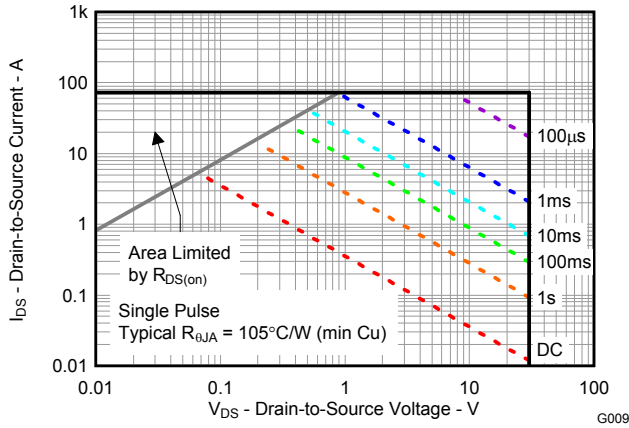**Figure 9. Typical Diode Forward Voltage**
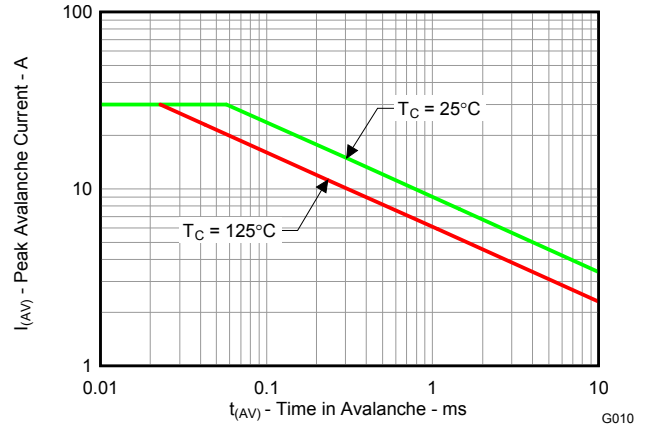
**Figure 10. Maximum Safe Operating Area**

**Figure 11. Single Pulse Unclamped Inductive Switching**
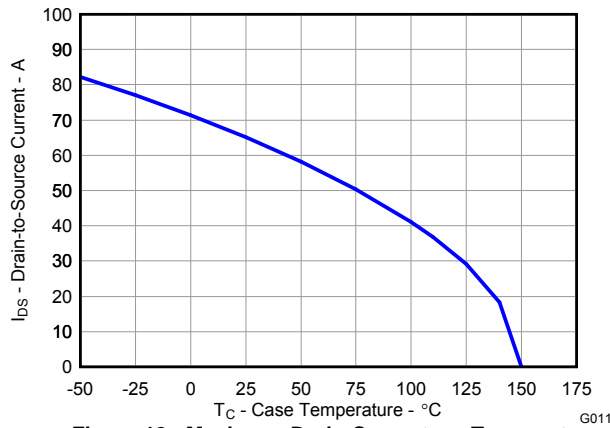
**Figure 12.  Maximum Drain Current vs. Temperature**

## MECHANICAL DATA

### Q5A Package Dimensions



**Top View**

**Side View**

**Bottom View**



**Front View**

M0135-01

| DIM | MILLIMETERS | | |
|-----|-----|-----|-----|
| | **MIN** | **NOM** | **MAX** |
| A | 0.90 | 1.00 | 1.10 |
| b | 0.33 | 0.41 | 0.51 |
| c | 0.20 | 0.25 | 0.34 |
| D1 | 4.80 | 4.90 | 5.00 |
| D2 | 3.61 | 3.81 | 4.02 |
| E | 5.90 | 6.00 | 6.10 |
| E1 | 5.70 | 5.75 | 5.80 |
| E2 | 3.38 | 3.58 | 3.78 |
| e | 1.17 | 1.27 | 1.37 |
| H | 0.41 | 0.56 | 0.71 |
| K | 1.10 | | |
| L | 0.51 | 0.61 | 0.71 |
| L1 | 0.06 | 0.13 | 0.20 |
| θ | 0° | | 12° |

![Texas Instruments] CSD17527Q5A

## Recommended PCB Pattern
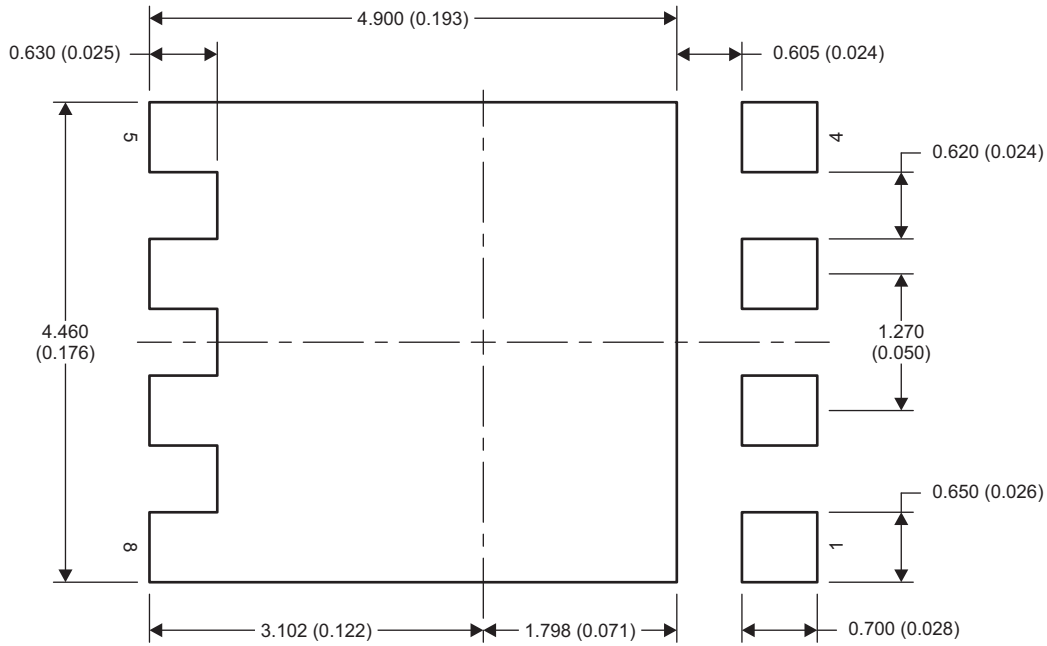


NOTE: Dimensions are in mm (inches).

## Stencil Recommendation



NOTE: Dimensions are in mm (inches).

For recommended circuit layout for PCB designs, see application note SLPA005 – *Reducing Ringing Through PCB Layout Techniques.*
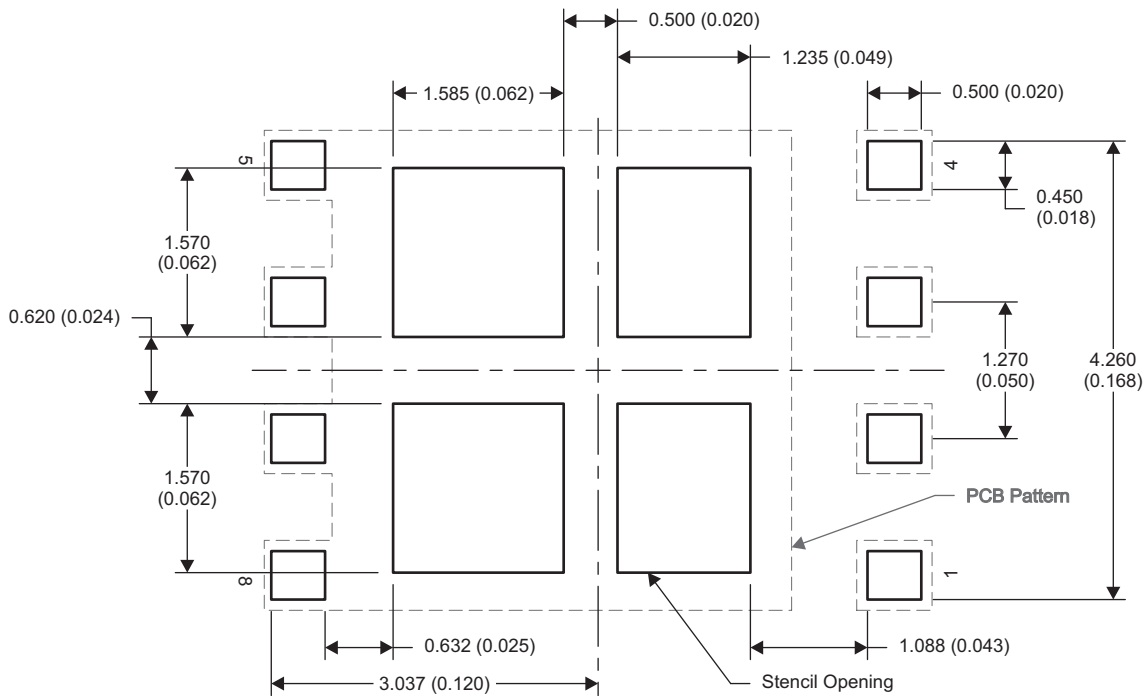
## Q5A Tape and Reel Information

A0 = 6.50 ±0.10
B0 = 5.30 ±0.10
K0 = 1.40 ±0.10
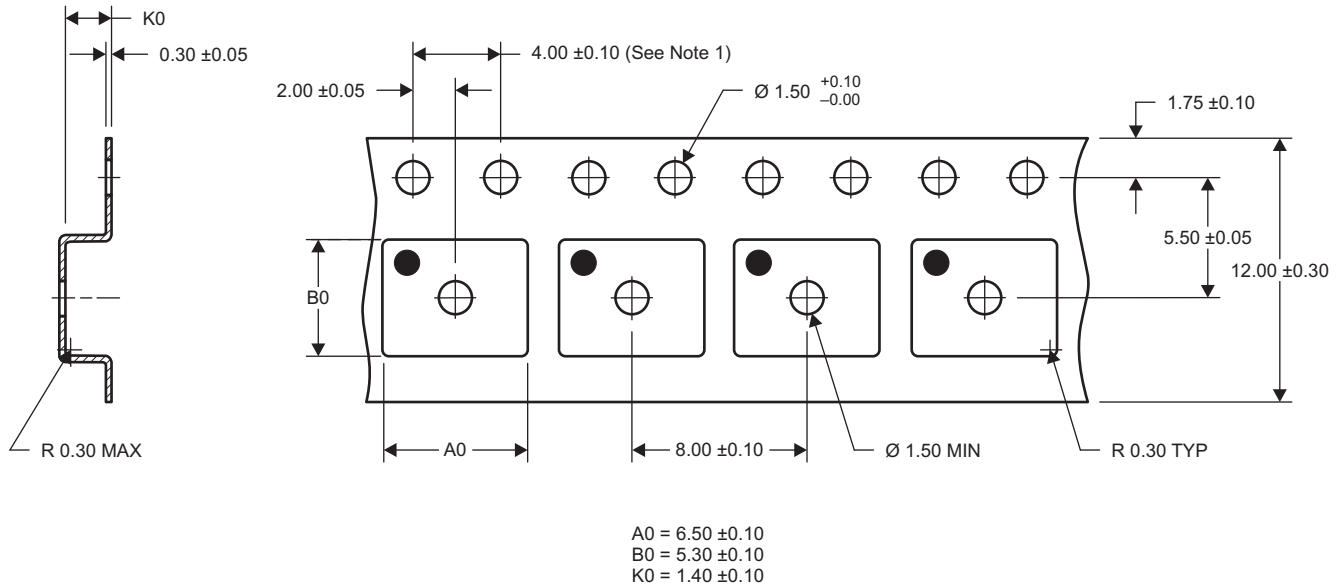
M0138-01

NOTES: 1. 10-sprocket hole-pitch cumulative tolerance ±0.2

2. Camber not to exceed 1mm in 100mm, noncumulative over 250mm

3. Material: black static-dissipative polystyrene

4. All dimensions are in mm (unless otherwise specified)

5. A0 and B0 measured on a plane 0.3mm above the bottom of the pocket

# REVISION HISTORY

**Changes from Original (June 2011) to Revision A**                                                   **Page**

## PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|---|---|---|---|---|---|---|---|---|---|---|---|
| CSD17527Q5A | ACTIVE | VSONP | DQJ | 8 | 2500 | RoHS-Exempt & Green | SN | Level-1-260C-UNLIM | -55 to 150 | CSD17527 | Samples |

**(1)** The marketing status values are defined as follows:
**ACTIVE:** Product device recommended for new designs.
**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.
**OBSOLETE:** TI has discontinued the production of the device.

**(2) RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

**(3)** MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**(4)** There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

**(5)** Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

**(6)** Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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